

# High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

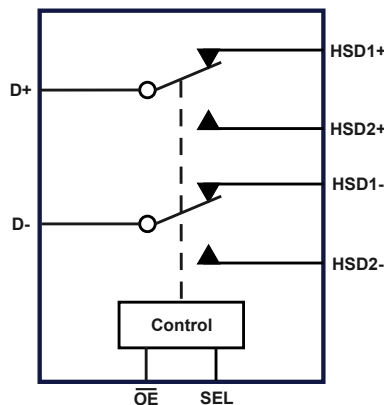
## Features

- $V_{CC}$  Supply Voltage: 1.8 V to 5.5 V
- $V_{I/O}$  Accepts Signals up to 5.5 V
- 1.8-V Compatible Control-Pin Inputs (S,  $\overline{OE}$ )
- Low-Power Mode When OE is Disabled (1  $\mu$ A)
- $R_{ON} = 7.3 \Omega$  Typical at 3 V
- $\Delta R_{ON} = 0.8 \Omega$  Typical
- $C_{io(on)} = 3.6$  pF
- Low Power Consumption (7  $\mu$ A)
- High Bandwidth: 2.5 GHz
- Break-Before-Make Switching
- Operation Temperature Range:  $-40^{\circ}C$  to  $125^{\circ}C$

## Applications

- Industry Control Systems
- Mobile Phones
- Routes Signals for USB 1.0, 1.1, and 2.0
- Notebooks
- USB I/O Expansion

## Block Diagram and Function Table



$\overline{OE}$	S	HSD1+, HSD1-	HSD2+, HSD2-
Low	Low	ON	OFF
Low	High	OFF	ON
High	X	OFF	OFF

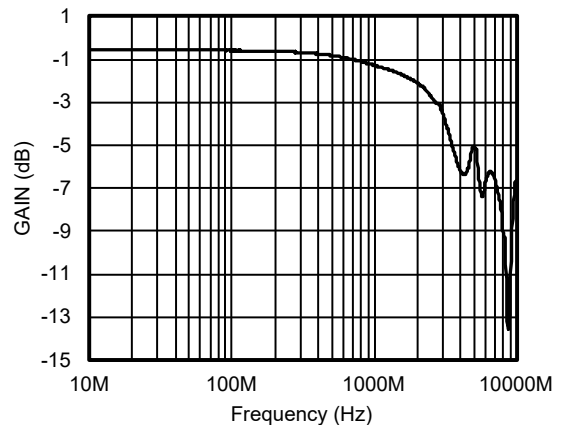
NOTE: Switches shown for logic "0" input.

## Description

The TPW3227 is a high-bandwidth analog switch designed for the switching of high-speed USB 2.0 signals in handsets and consumer electronics, such as notebooks and mobile phones, especially those equipped with hubs and controllers featuring limited USB I/Os. The device operates over the wide  $V_{CC}$  range from 1.8 V to 5.5 V.

The wide bandwidth (2.5 GHz) of the TPW3227 allows signals to pass with minimum edge, delay, and phase distortion. The device multiplexes differential output from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The switch consumes very low quiescent current less than 1  $\mu$ A in a low power mode and is suitable for portable applications with a battery or limited power budget. The device has a very low bit-to-bit skew and excellent channel-to-channel crosstalk to fit applications with high channel-to-channel crosstalk requirements.

The TPW3227 device integrates ESD protection cells on all pins, is available in a tiny UTQFN package (1.4 mm x 1.8 mm), and is characterized over the free air temperature range from  $-40^{\circ}C$  to  $125^{\circ}C$ .

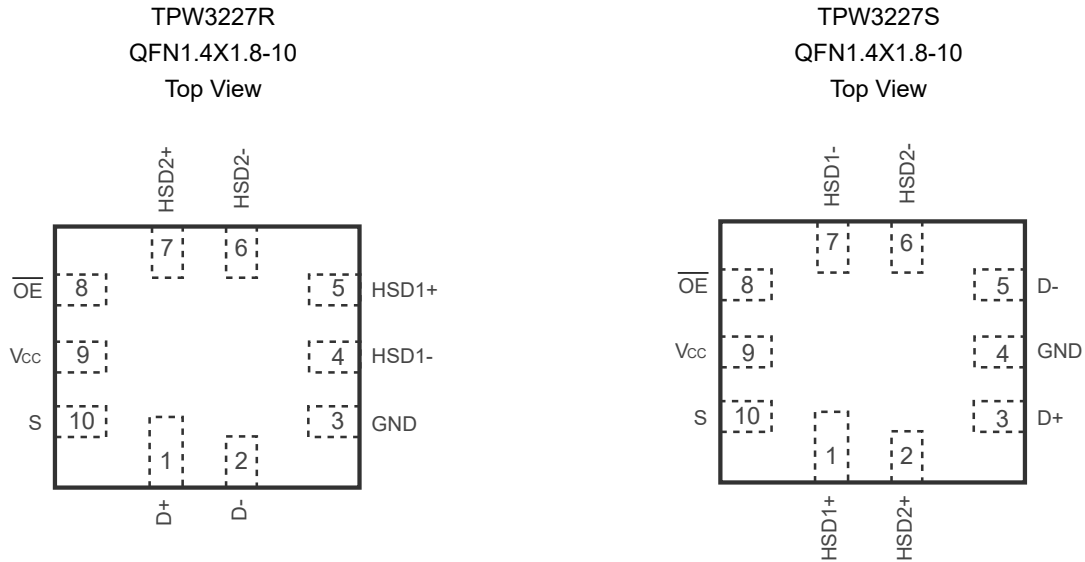


## Table of Contents

<b>Features</b> .....	<b>1</b>
<b>Applications</b> .....	<b>1</b>
<b>Block Diagram and Function Table</b> .....	<b>1</b>
<b>Description</b> .....	<b>1</b>
<b>Revision History</b> .....	<b>3</b>
<b>Pin Configuration and Functions</b> .....	<b>4</b>
<b>Specifications</b> .....	<b>5</b>
Absolute Maximum Ratings <sup>(1)</sup> .....	5
ESD, Electrostatic Discharge Protection.....	5
Recommended Operating Conditions <sup>(1)</sup> .....	5
Thermal Information.....	5
Electrical Characteristics.....	6
Typical Performance Characteristics.....	9
Test Circuit and Waveforms.....	11
<b>Application and Implementation</b> .....	<b>13</b>
Application Information .....	13
<b>Tape and Reel Information</b> .....	<b>14</b>
<b>Package Outline Dimensions</b> .....	<b>15</b>
QFN1.4X1.8-10.....	15
<b>Order Information</b> .....	<b>16</b>
<b>IMPORTANT NOTICE AND DISCLAIMER</b> .....	<b>17</b>

## Revision History

Date	Revision	Notes
2025-07-12	Rev.A.0	Initial Version.
2025-09-08	Rev.A.1	The following updates are all about the new datasheet formats or typos, and the actual product remains unchanged. <ul style="list-style-type: none"><li>• Changed the image in the Description.</li><li>• Added Eye Diagrams and Jitter Images.</li><li>• Adjusted some description and EC table format.</li></ul>

**Pin Configuration and Functions**

**Table 1. Pin Functions : TPW3227**

Pin No.		Name	I/O	Description
TPW3227R	TPW3227S			
1	3	D+	I/O	Common port
2	5	D-	I/O	Common Port
3	4	GND		Ground
4	7	HSD1-	I/O	Switch port 1
5	1	HSD1+	I/O	Switch port 1
6	6	HSD2-	I/O	Switch port 2
7	2	HSD2+	I/O	Switch port 2
8	8	$\overline{OE}$	I	Bus-switch enable
9	9	V <sub>cc</sub>		Power supply
10	10	S	I	Select input

**Table 2. Function Table**

$\overline{OE}$	S	HSD1+, HSD1-	HSD2+, HSD2-
Low	Low	ON	OFF
Low	High	OFF	ON
High	X	OFF	OFF

## High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

### Specifications

#### Absolute Maximum Ratings <sup>(1)</sup>

Parameter		Min	Max	Unit
	Supply Voltage, $V_{CC}$	0	6.5	V
	Control Input Voltage, $V_S, V_{\overline{OE}}$	-0.3	6.5	V
	Switch I/O Port Voltage	-0.3	6.5	V
	On-state Switch Continuous Current	-50	+50	mA
	On-state Switch Peak Current	-100	+100	mA
$T_J$	Maximum Junction Temperature		125	°C
$T_{STG}$	Storage Temperature Range	-65	150	°C
$T_L$	Lead Temperature (Soldering, 10 sec)		260	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

#### ESD, Electrostatic Discharge Protection

Symbol	Parameter	Condition	Minimum Level	Unit
HBM	Human Body Model ESD	ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4	kV
CDM	Charged Device Model ESD	ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±1.5	kV

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### Recommended Operating Conditions <sup>(1)</sup>

All test conditions: over the operating temperature range, unless otherwise noted.

Parameter	Min	Max	Unit
Supply Voltage, $V_{CC}$	1.8	5.5	V
Control Input Voltage, $V_S, V_{\overline{OE}}$	0	5.5	V
Switch I/O Port Voltage	0	$V_{CC}$	V
Operating Temperature Range	-40	125	°C

(1) The control input must be held HIGH or LOW and must not float.

#### Thermal Information

Package Type	$\theta_{JA}$	$\theta_{JC}$	Unit
QFN1.4X1.8-10	150	100	°C/W

**High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch**
**Electrical Characteristics**

 All test conditions: over operating temperature range, typical at  $T_A = 25^\circ\text{C}$ , unless otherwise noted.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Power Supply</b>						
$I_{CC}$	Active Supply Current	$V_{CC} = 5.5\text{ V}$ , $\overline{OE} = 0\text{ V}$ , $S = 0\text{ V}$ or $V_{CC}$ , $V_{I/O} = 0\text{ V}$ or floating		4.5	7	$\mu\text{A}$
$I_{STDN}$	Shutdown Supply Current (low power mode)	$V_{CC} = 5.5\text{ V}$ , $\overline{OE} = V_{CC}$ , $S = 0\text{ V}$ or $V_{CC}$ , $V_{I/O} = 0\text{ V}$ or floating			1	$\mu\text{A}$
$\Delta I_{CC}$	Increase in $I_{CC}$ per Input	$V_{CC} = 5.5\text{ V}$ , One input at 1.8 V, others at $V_{CC}$ or GND			12	$\mu\text{A}$
<b>Digital Input</b>						
$V_{IH}$	Input Voltage High, control pin ( $\overline{OE}$ , S)		1.5			V
$V_{IL}$	Input Voltage Low, control pin ( $\overline{OE}$ , S)				0.5	V
$I_{IN}$	Control Input Leakage	$V_{CC} = 5.5\text{ V}$ , $V_{IN} = 0\text{ V}$ or $V_{CC}$	-1		1	$\mu\text{A}$
<b>Analog Switch</b>						
$R_{ON}$	ON-state Resistance	$V_{CC} = 3\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 0.4 V		7.3	11	$\Omega$
		$V_{CC} = 5\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 0.4 V		5.6	8	$\Omega$
$\Delta R_{ON}$	ON-state Resistance Match between Channels	$V_{CC} = 3\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 0.4 V		0.8	1	$\Omega$
		$V_{CC} = 5\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 0.4 V		0.8	1	$\Omega$
$R_{FLAT(ON)}$	On-state Resistance Flatness	$V_{CC} = 3\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 1 V		0.04	0.2	$\Omega$
		$V_{CC} = 5\text{ V}$ , $I_{OUT} = 8\text{ mA}$ , $V_{IN} = 0\text{ V}$ to 1 V		0.04	0.2	$\Omega$
$I_{D(OFF)}$	Power OFF Leakage Current on D	$V_{CC} = 0\text{ V}$ , $\overline{OE}$ , $S = 0\text{ V}$ or 3.6 V, $V_D = 0\text{ V}$ to 3.6 V, HSDn floating	-1		1	$\mu\text{A}$
		$V_{CC} = 0\text{ V}$ , $\overline{OE}$ , $S = 0\text{ V}$ or 5.5 V, $V_D = 0\text{ V}$ to 5.5 V, HSDn floating	-1		1	$\mu\text{A}$
$I_{HSD(OFF)}$	Switch OFF Leakage Current on HSDn	$V_{CC} = 3.6\text{ V}$ , $\overline{OE} = V_{CC}$ , $S = 0\text{ V}$ or $V_{CC}$ , $V_D = 3.3\text{ V}$ , 0.3 V, $V_{HSDn} = 0.3\text{ V}$ , 3.3 V	-1		1	$\mu\text{A}$
		$V_{CC} = 5.5\text{ V}$ , $\overline{OE} = V_{CC}$ , $S = 0\text{ V}$ or $V_{CC}$ , $V_D = 4.5\text{ V}$ , 1 V, $V_{HSDn} = 1\text{ V}$ , 4.5 V	-1		1	$\mu\text{A}$

**High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$I_{HSD(ON)}$	Switch ON Leakage Current on HSDn	$V_{CC} = 3.6\text{ V}$ , $\overline{OE} = 0\text{ V}$ , $S = 0\text{ V}$ or $V_{CC}$ , D floating, $V_{HSDn} = 0.3\text{ V}$ or $3.3\text{ V}$	-1		1	$\mu\text{A}$
		$V_{CC} = 5.5\text{ V}$ , $\overline{OE} = 0\text{ V}$ , $S = 0\text{ V}$ or $V_{CC}$ , D floating, $V_{HSDn} = 1\text{ V}$ or $4.5\text{ V}$	-1		1	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$t_{PD}$	Propagation Delay	$V_{CC} = 3.3\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 17</a>		50		ps
		$V_{CC} = 5\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 17</a>		50		ps
skew	Output Skew Between Channels	$V_{CC} = 3.3\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$		10		ps
		$V_{CC} = 5\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$		10		ps
$t_{ON}$	Switch Turn-on Time	$V_{CC} = 3.3\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 11</a>		40		ns
		$V_{CC} = 5\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 11</a>		30		ns
$t_{OFF}$	Switch Turn-off Time	$V_{CC} = 3.3\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 11</a>		15		ns
		$V_{CC} = 5\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 11</a>		15		ns
$t_B$	Break-Before-Make Time	$V_{CC} = 3.3\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 12</a>		30		ns
		$V_{CC} = 5\text{ V}$ , $V_{IN} = 0.8\text{ V}$ , $R_L = 50\ \Omega$ , $C_L = 10\text{ pF}$ , <a href="#">Figure 12</a>		22		ns
Q	Charge Injection	$V_{CC} = 3.3\text{ V}$ , $C_L = 1.0\text{ nF}$ , $V_{GEN} = 0\text{ V}$ , $R_{GEN} = 0\ \Omega$ , <a href="#">Figure 13</a>		4		pC
		$V_{CC} = 5\text{ V}$ , $C_L = 1.0\text{ nF}$ , $V_{GEN} = 0\text{ V}$ , $R_{GEN} = 0\ \Omega$ , <a href="#">Figure 13</a>		5.5		pC
OISO	OFF-Isolation	$V_{CC} = 3.3\text{ V}$ , $f = 250\text{ MHz}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 14</a>		-24		dB
		$V_{CC} = 5\text{ V}$ , $f = 250\text{ MHz}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 14</a>		-24		dB
XTALK	Crosstalk	$V_{CC} = 3.3\text{ V}$ , $f = 250\text{ MHz}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 15</a>		-40		dB
		$V_{CC} = 5\text{ V}$ , $f = 250\text{ MHz}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 15</a>		-40		dB
BW	Bandwidth	$V_{CC} = 3.3\text{ V}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 16</a>		2500		MHz
		$V_{CC} = 5\text{ V}$ , $R_L = 50\ \Omega$ , <a href="#">Figure 16</a>		2500		MHz
<b>Capacitance</b>						

---

**High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C <sub>ON</sub>	On Capacitance	V <sub>CC</sub> = 3.3 V, f = 1 MHz, f = 30 MHz		3.6		pF
C <sub>ON</sub>	On Capacitance	V <sub>CC</sub> = 3.3 V, f = 250 MHz		1.8		pF

(1) C<sub>ON</sub> is guaranteed by simulation.



# High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch



Figure 7. 3 Gbps Eye Diagram



Figure 8. 3 Gbps Jitter

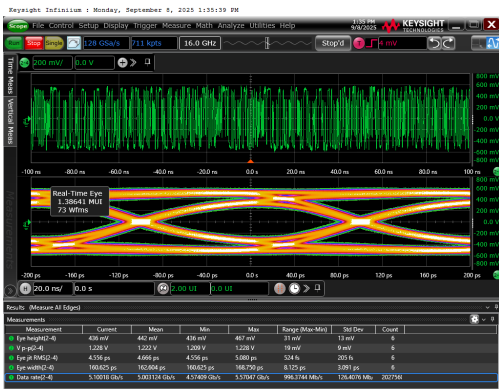


Figure 9. 5 Gbps Eye Diagram



Figure 10. 5 Gbps Jitter

# High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

## Test Circuit and Waveforms

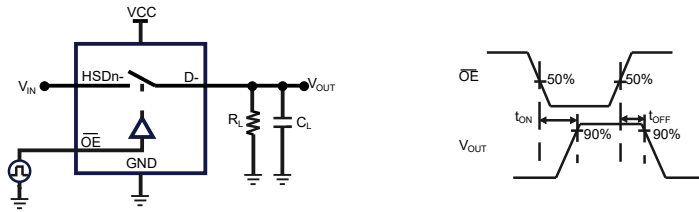


Figure 11. AC Test Circuit and Test Waveforms

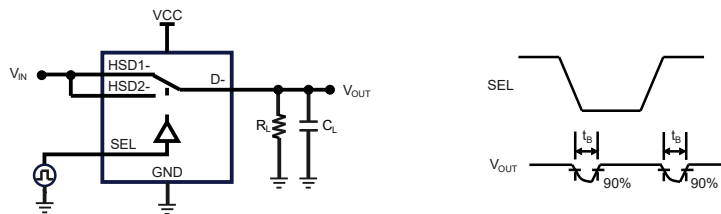


Figure 12. Switch Break Time

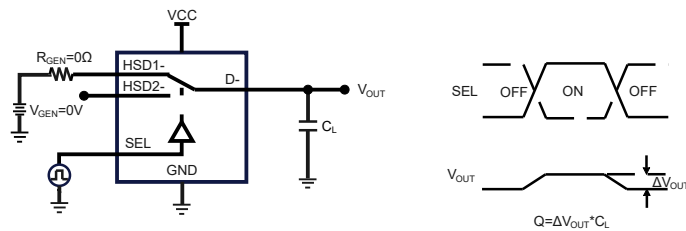


Figure 13. Charge Injection

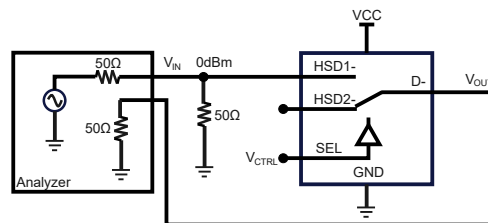


Figure 14. Off Isolation

High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

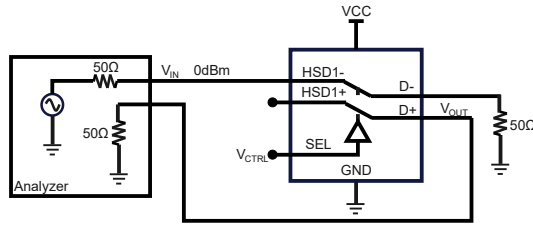


Figure 15. Crosstalk

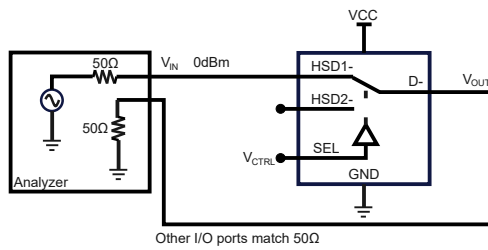


Figure 16. Bandwidth

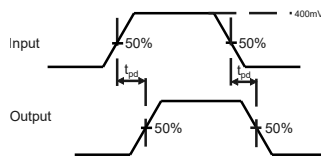


Figure 17. Propagation Delay

---

## High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

### Application and Implementation

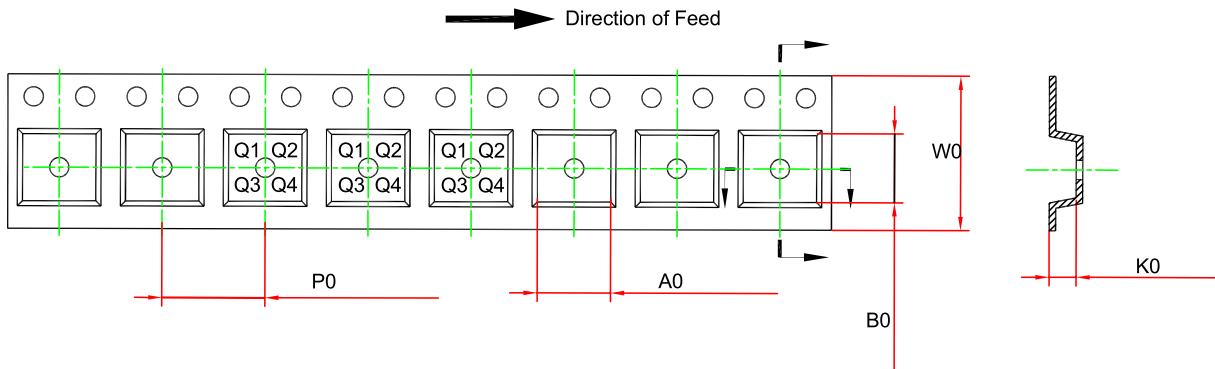
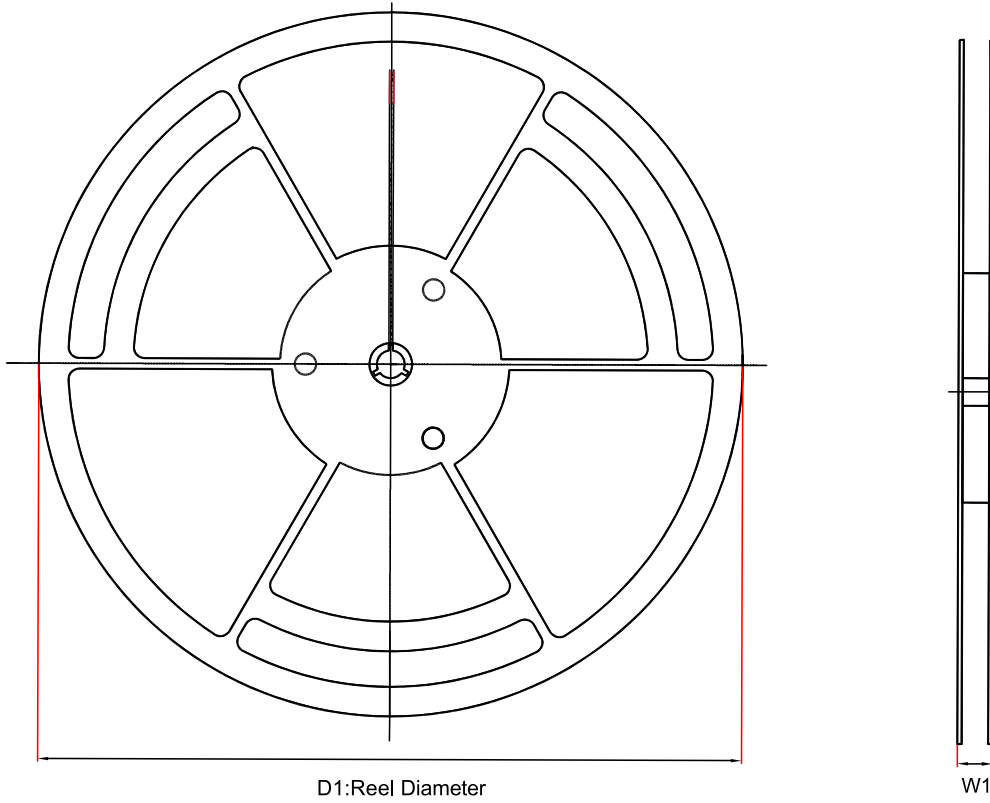
Note

Information in the following application sections is not part of the 3PEAK's component specification and 3PEAK does not warrant its accuracy or completeness. 3PEAK's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### Application Information

A 0.1- $\mu$ F bypass capacitor on  $V_{CC}$  and GND is recommended to prevent power disturbance.

Tape and Reel Information



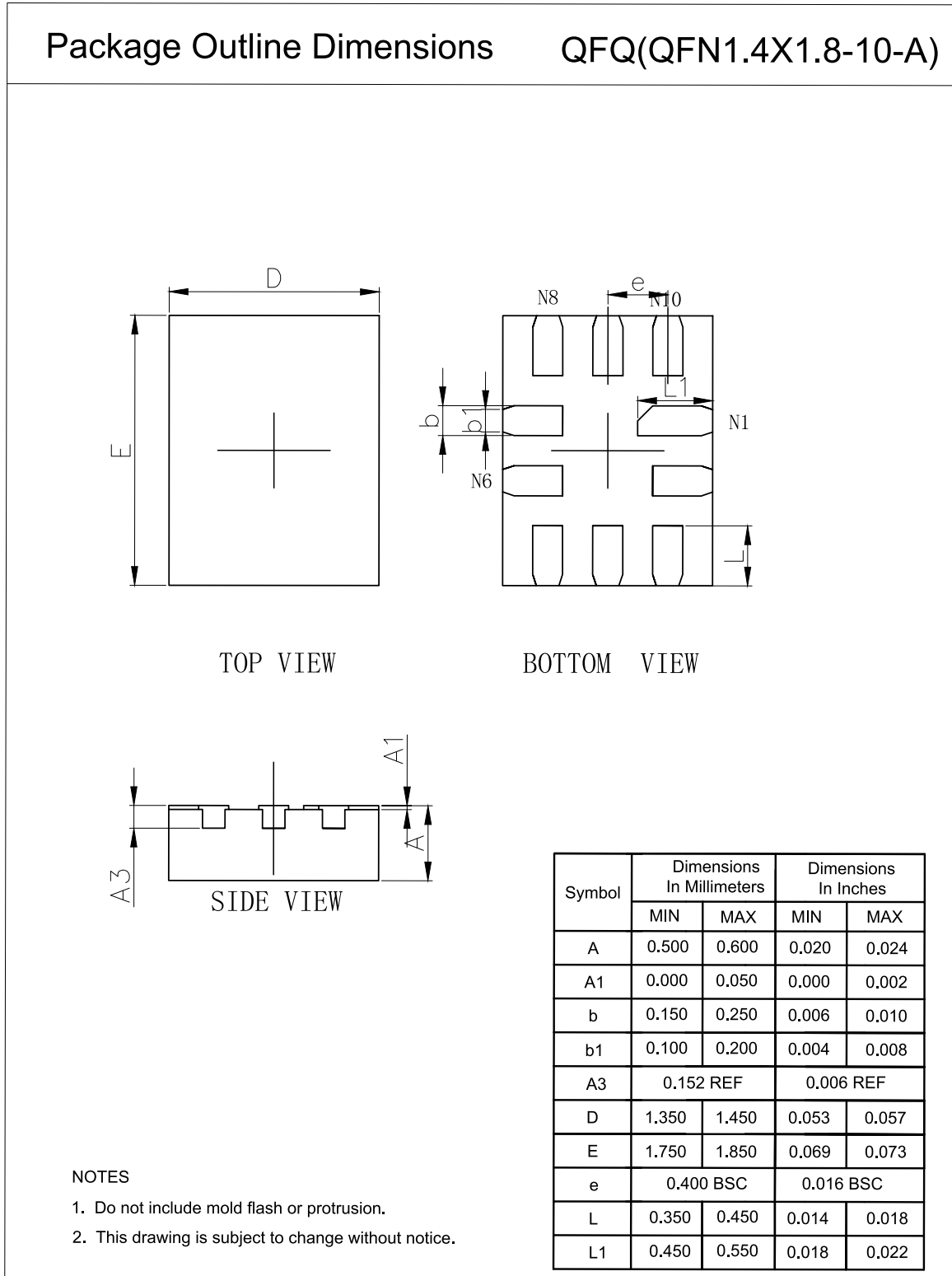
Order Number	Package	D1 (mm)	W1 (mm)	A0 (mm) <sup>(1)</sup>	B0 (mm) <sup>(1)</sup>	K0 (mm) <sup>(1)</sup>	P0 (mm)	W0 (mm)	Pin1 Quadrant
TPW3227R-QFQR	QFN1.4X1.8-10	180.0	13.1	1.6	2	0.85	4.00	8.00	Q1
TPW3227S-QFQR	QFN1.4X1.8-10	180.0	13.1	1.6	2	0.85	4.00	8.00	Q1

(1) The value is for reference only. Contact the 3PEAK factory for more information.

High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

Package Outline Dimensions

QFN1.4X1.8-10



---

**High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch****Order Information**

Order Number	Operating Temperature Range	Package	Marking Information	MSL	Transport Media, Quantity	Eco Plan
TPW3227R-QFQR	-40 to 125°C	QFN1.4X1.8-10	AAF	MSL3	Tape and Reel,4000	Green
TPW3227S-QFQR <sup>(1)</sup>	-40 to 125°C	QFN1.4X1.8-10	AAG	MSL3	Tape and Reel,4000	Green

(1) For future products, contact the 3PEAK factory for more information and samples.

**Green:** 3PEAK defines "Green" to mean RoHS compatible and free of halogen substances.

---

## High-Speed 1:2 Multiplexer and Demultiplexer Analog Switch

### IMPORTANT NOTICE AND DISCLAIMER

**Copyright**© 3PEAK 2012-2025. All rights reserved.

**Trademarks.** Any of the 思瑞浦 or 3PEAK trade names, trademarks, graphic marks, and domain names contained in this document /material are the property of 3PEAK. You may NOT reproduce, modify, publish, transmit or distribute any Trademark without the prior written consent of 3PEAK.

**Performance Information.** Performance tests or performance range contained in this document/material are either results of design simulation or actual tests conducted under designated testing environment. Any variation in testing environment or simulation environment, including but not limited to testing method, testing process or testing temperature, may affect actual performance of the product.

**Disclaimer.** 3PEAK provides technical and reliability data (including data sheets), design resources (including reference designs), application or other design recommendations, networking tools, security information and other resources "As Is". 3PEAK makes no warranty as to the absence of defects, and makes no warranties of any kind, express or implied, including without limitation, implied warranties as to merchantability, fitness for a particular purpose or non-infringement of any third-party's intellectual property rights. Unless otherwise specified in writing, products supplied by 3PEAK are not designed to be used in any life-threatening scenarios, including critical medical applications, automotive safety-critical systems, aviation, aerospace, or any situations where failure could result in bodily harm, loss of life, or significant property damage. 3PEAK disclaims all liability for any such unauthorized use.

This page intentionally left blank